

<b>Notice of References Cited</b>	Application/Control No. 09/802,955		Applicant(s)/Patent Under Reexamination ABE, TETSUYA	
	Examiner Chriss S. Yoder, III		Art Unit 2612	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,028,981 A	02-2000	Hirasawa et al.	386/117
	B	US-5,486,893 A	01-1996	Takagi, Tadao	396/147
	C	US-6,343,147 B2	01-2002	Yamamoto, Nobuo	382/167
	D	US-5,654,753	08-1997	Takei, Hirohumi	348/223.1
	E	US-2001/0043279	11-2001	Niikawa et al.	348/335
	F	US-4,714,955	12-1987	Nishimura et al.	348/237
	G	US-6,788,812 B1	09-2004	Wilkins, David C.	382/167
	H	US-6,650,365 B1	11-2003	Sato, Koichi	348/231.3
	I	US-5,198,890 A	03-1993	Suga, Akira	348/227.1
	J	US-5,751,349 A	05-1998	Matsui et al.	348/228.1
	K	US-6,665,015 B1	12-2003	Watanabe et al.	348/362
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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